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CLAIMS

What is claimed is:

- 1. An integrated circuit semiconductor-on-insulator structure, comprising:
 - a pair of matched transistors, in a circuit stage which requires matched behavior of said pair; and
- a physical connection of semiconductor material which provides thermal conduction between respective bodies of said pair of transistors, but does not carry current during normal operation of said circuit stage; and
 - an insulating material which totally surrounds at least part of said circuit stage.
 - 2. The integrated circuit of Claim 1, wherein said circuit stage is an analog circuit stage.
 - 3. The integrated circuit of Claim 1, wherein said circuit stage is a matched pair of current-sourcing P-channel transistors in a current mirror.
 - 4. The integrated circuit of Claim 1, wherein said circuit stage is a cascode pair.

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- 5. The integrated circuit of Claim 1, wherein said circuit stage is an input pair of a differential analog stage.
- 6. An integrated semiconductor-on-insulator circuit structure, comprising:
 - a pair of transistors in an analog circuit stage which requires matched behavior of said pair;
- a physical connection of metallic material which provides thermal conduction between respective bodies of said pair of transistors, but does not carry current during normal operation of said circuit stage; and

an insulating layer beneath said pair;

- an insulating barrier substantially surrounding said pair and extending to said insulating layer.
 - 7. The integrated circuit of Claim 6, wherein said analog circuit stage is a current mirror.
 - 8. The integrated circuit of Claim 6, wherein said analog circuit stage is a matched pair of current-sourcing P-channel transistors in a current mirror.
 - 9. The integrated circuit of Claim 6, wherein said physical connection comprises metal interconnects between said transistors of said pair.

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- 10. An integrated semiconductor-on-insulator circuit structure, comprising:
 - a plurality of matched transistors in an analog circuit stage which requires matched behavior of said transistors;
- wherein respective bodies of said transistors are formed from different semiconductor sections, said sections being formed on an insulating layer and at least partially separated by insulating material;
- wherein said bodies are not tied to any fixed potential; and
 wherein said bodies are thermally coupled by a connection of noninsulating material.
 - 11. The integrated circuit of Claim 10, wherein said bodies are electrically coupled by a connection of non-insulating material.
 - 12. The integrated circuit of Claim 10, wherein said analog circuit stage is a current mirror.
 - 13. The integrated circuit of Claim 10, wherein said connection of non-insulating material is made from semiconductor material.
 - 14. The integrated circuit of Claim 10, wherein said analog circuit stage is a current mirror.
 - 15. The integrated circuit of Claim 10, wherein said analog circuit stage is a matched pair of current-sourcing P-channel transistors in a current mirror.

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- 16. A method of circuit operation, comprising the steps of:
 providing a pair of matched transistors, in a circuit stage which requires matched behavior of said pair; and
 providing a physical connection of material which provides thermal conduction between respective bodies of said pair of transistors; and
 surrounding said circuit stage with an insulating material.
 - 17. The method of Claim 16, wherein said physical connection is of a semiconductor material.
 - 18. The method of Claim 16, wherein said circuit stage is an analog circuit stage.
 - 19. The method of Claim 16, wherein said physical connection does not carry current during normal operation of said circuit stage.

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